

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of )  
Gerhard Bonnet et al. ) Group:  
Serial No. )  
Filed: ) Examiner:  
Title: METHOD AND DEVICE FOR )  
MEASURING DISTANCE )

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Applicant wishes to bring to the attention of the Examiner the documents identified on the attached form PTO-1449. Applicant respectfully requests that these documents be made of record in the present application.

REMARKS:

WO 01/61302, EP 1 258 718, US 4,579,417, JP 2002 005614 and JP 2000 081374 are cited in an International Search Report dated July 3, 2003 in PCT/DE03/00106.

DE 100 45 535 is cited on page 2 of the specification.

US 2003/0184760 is the English language equivalent of DE 100 45 535.

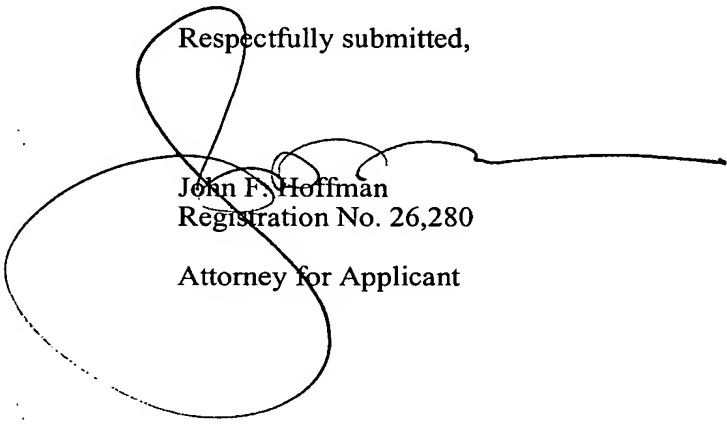
EP 1 258 718 is the English language equivalent of WO 01/61302.

Also filed concurrently, an application entitled "Imaging Device for Recording Depth" based on PCT/DE03/00154, filed January 20, 2003. A copy of the first page of the PCT published application is attached hereto.

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If any fees are necessary in connection with this document, or insufficient fees are sent herewith, please charge Deposit Account No. 02-0385, Baker & Daniels.

Respectfully submitted,

  
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Enc. Form PTO-1449  
Cited References

Date: July 15, 2004

# INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

Docket Number (Optional)

PTK0025

Application Number

10/501842

Applicant(s)

Klaas Bergman, et al

PT12 Filed PCT/PTO 15 JUL 2004

Filing Date

Group Art Unit

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		4,579,417	04/01/1986	Ih	350	96.11	

## U.S. PATENT APPLICATION PUBLICATIONS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		2003/0184760	10/02/2003	Bonnet	356	489	

## FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
		DE10045535	04/04/2002	Germany			✓	
		EP 1 258 718	11/20/2000	EPO				
		WO 01/61302	08/23/2001	PCT			✓	
		JP2002005614	01/09/2002	Japan				
		JP2000081374	03/21/2000	Japan				

## OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.